

# SEMiX 253GB126HDs



SEMiX<sup>®</sup> 3s

## Trench IGBT Modules

### SEMiX 253GB126HDs

#### Preliminary Data

#### Features

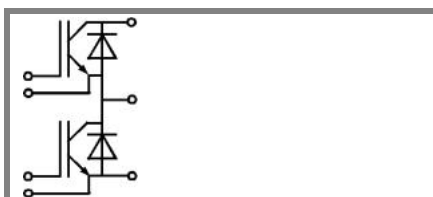
- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$  with positive temperature coefficient
- High short circuit capability

#### Typical Applications

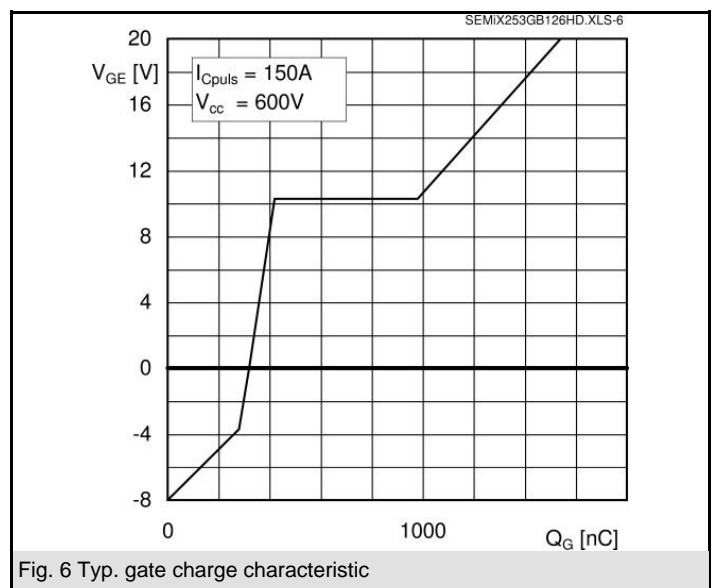
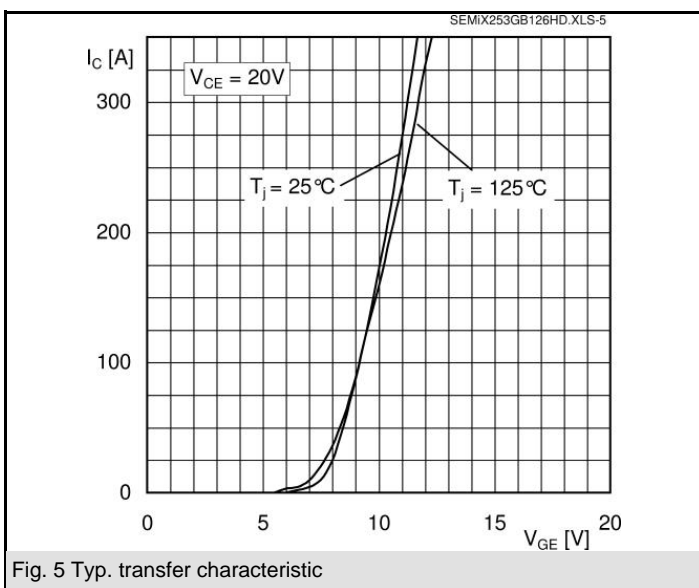
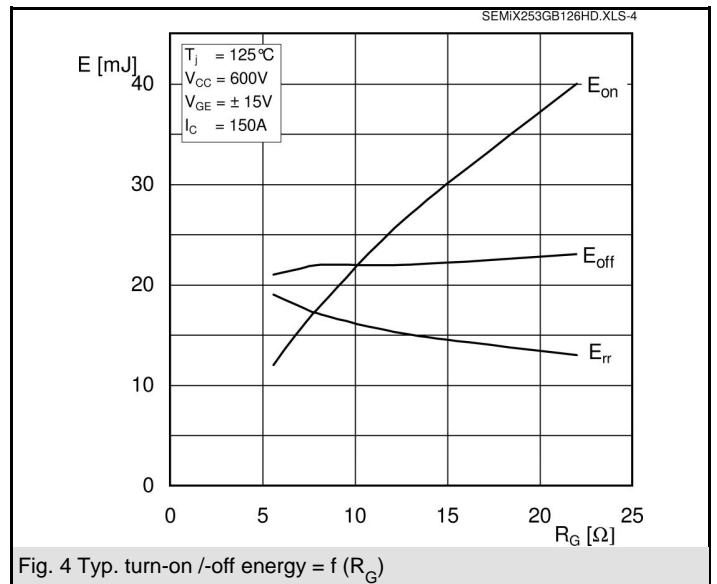
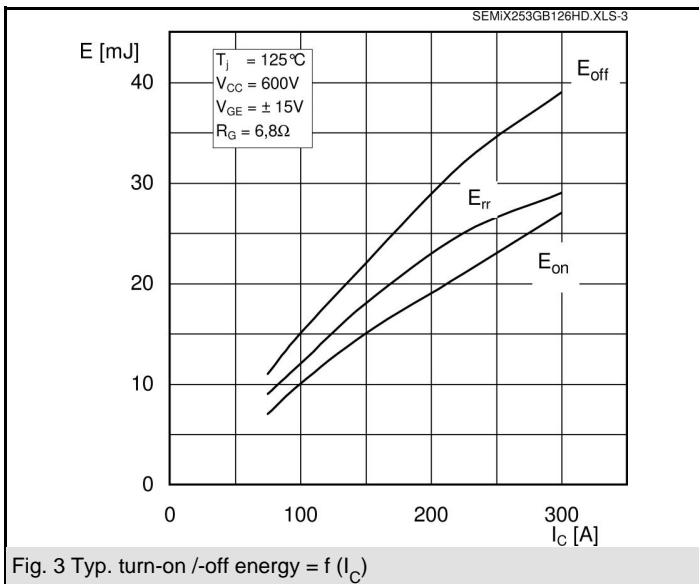
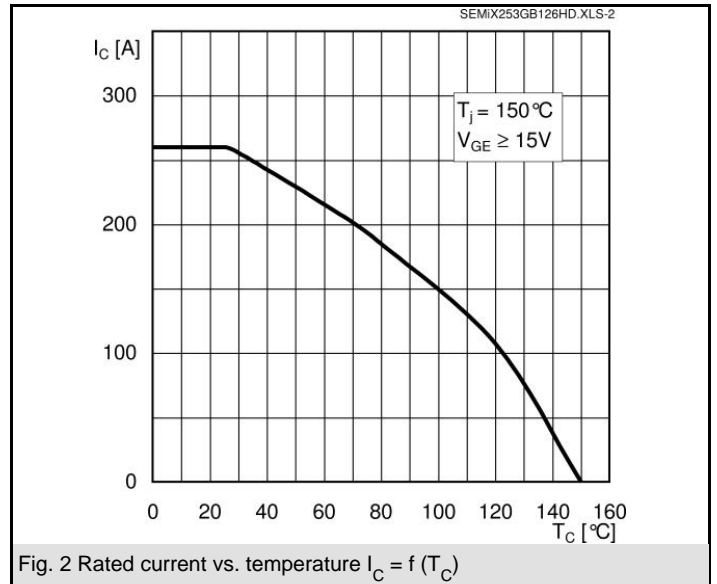
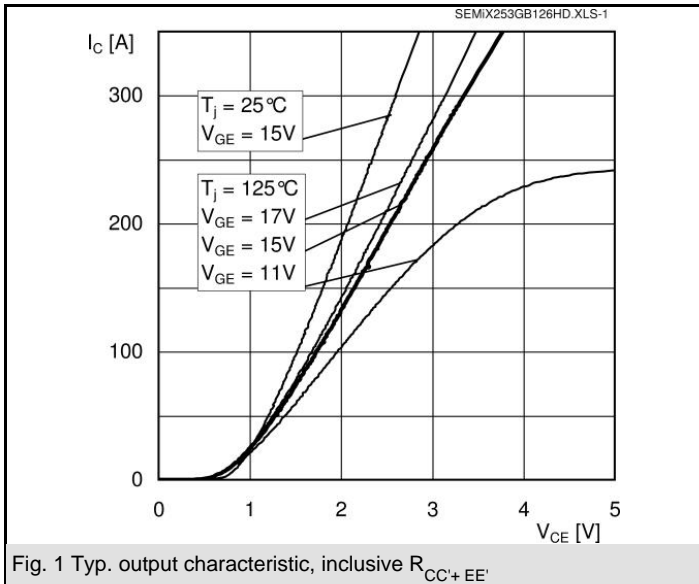
- AC inverter driver
- UPS
- Electronic welders

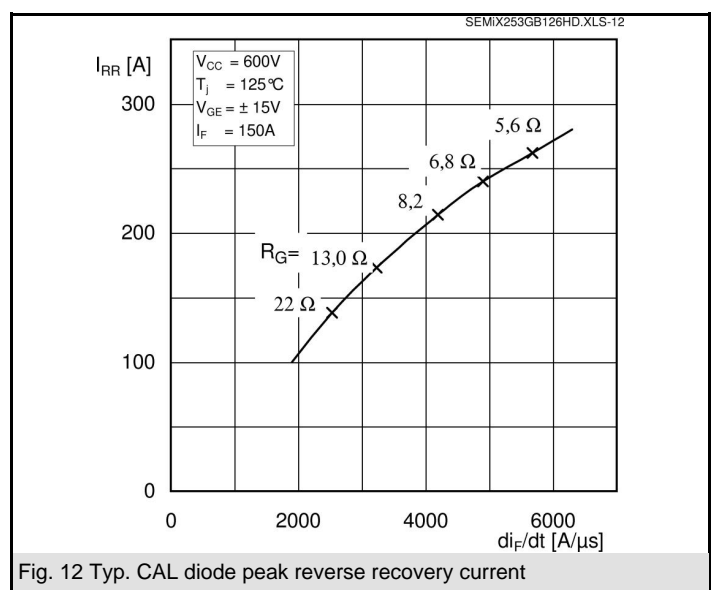
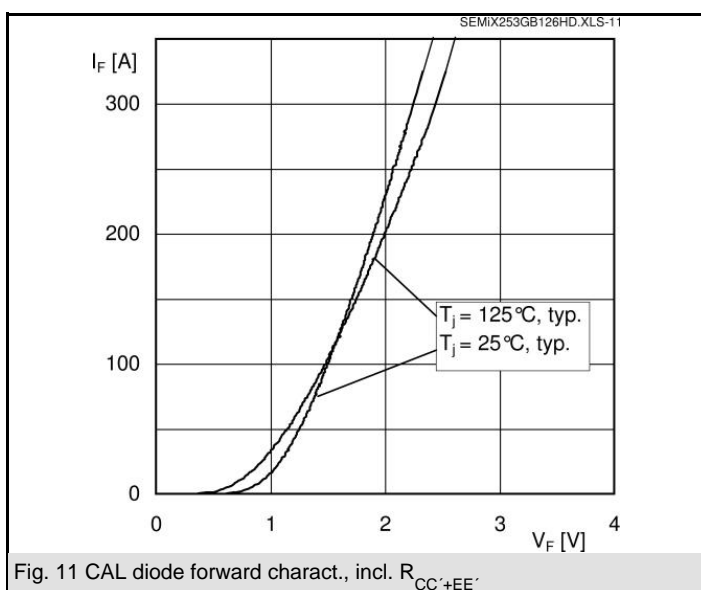
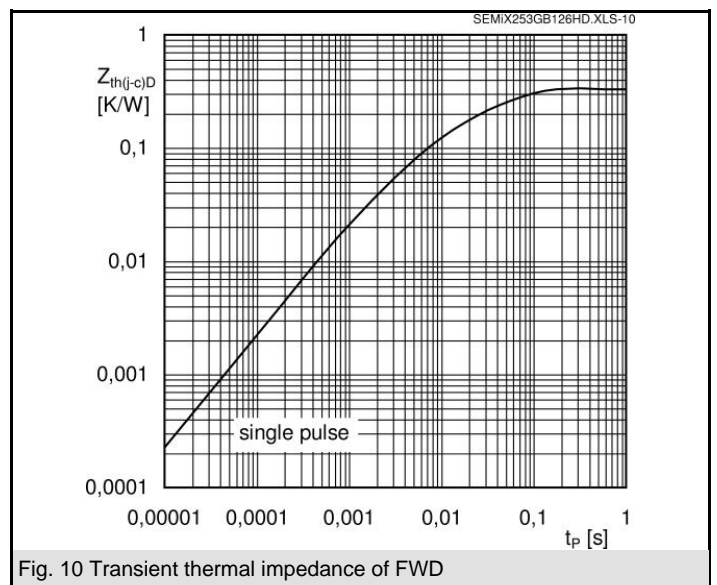
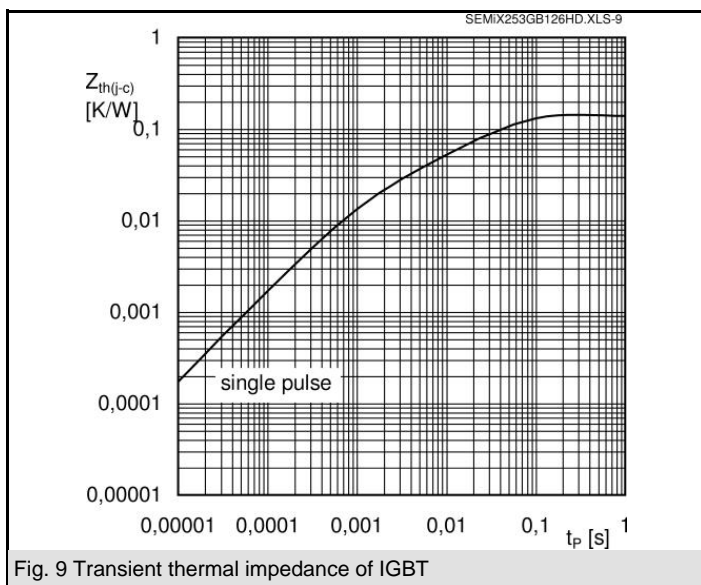
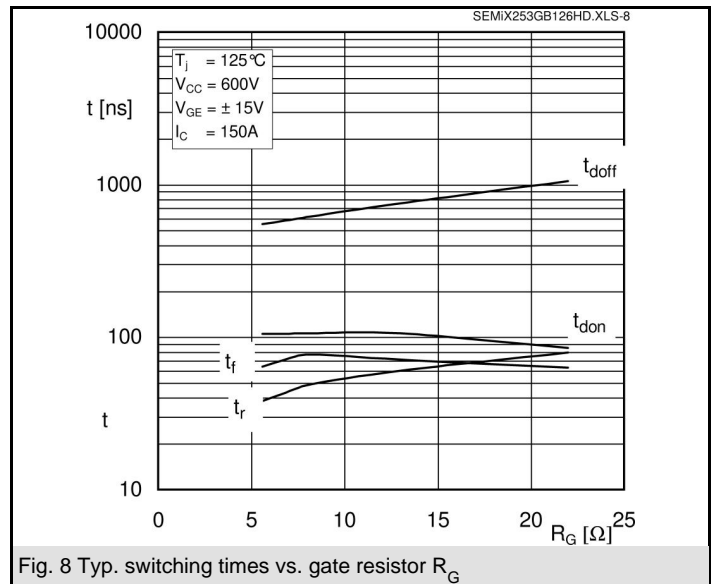
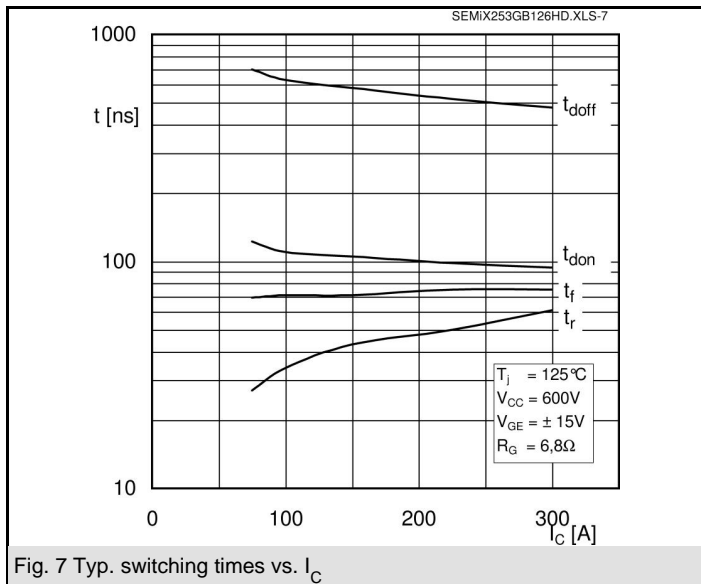
| Absolute Maximum Ratings |                                                            | $T_c = 25^\circ\text{C}$ , unless otherwise specified |                  |
|--------------------------|------------------------------------------------------------|-------------------------------------------------------|------------------|
| Symbol                   | Conditions                                                 | Values                                                | Units            |
| <b>IGBT</b>              |                                                            |                                                       |                  |
| $V_{CES}$                |                                                            | 1200                                                  | V                |
| $I_C$                    | $T_c = 25 (80)^\circ\text{C}$                              | 260 (190)                                             | A                |
| $I_{CRM}$                | $t_p = 1 \text{ ms}$                                       | 300                                                   | A                |
| $V_{GES}$                |                                                            | $\pm 20$                                              | V                |
| $T_{vj}$ ( $T_{stg}$ )   | $T_{OPERATION} \leq T_{stg}$                               | - 40 ... + 150 (125)                                  | $^\circ\text{C}$ |
| $V_{isol}$               | AC, 1 min.                                                 | 4000                                                  | V                |
| <b>Inverse diode</b>     |                                                            |                                                       |                  |
| $I_F$                    | $T_c = 25 (80)^\circ\text{C}$                              | 230 (160)                                             | A                |
| $I_{FRM}$                | $t_p = 1 \text{ ms}$                                       | 300                                                   | A                |
| $I_{FSM}$                | $t_p = 10 \text{ ms}; \text{sin.}; T_j = 25^\circ\text{C}$ | 1200                                                  | A                |

| Characteristics                |                                                                                              | $T_c = 25^\circ\text{C}$ , unless otherwise specified |            |             |               |
|--------------------------------|----------------------------------------------------------------------------------------------|-------------------------------------------------------|------------|-------------|---------------|
| Symbol                         | Conditions                                                                                   | min.                                                  | typ.       | max.        | Units         |
| <b>IGBT</b>                    |                                                                                              |                                                       |            |             |               |
| $V_{GE(th)}$                   | $V_{GE} = V_{CE}, I_C = 6 \text{ mA}$                                                        | 5                                                     | 5,8        | 6,5         | V             |
| $I_{CES}$                      | $V_{GE} = 0, V_{CE} = V_{CES}, T_j = 25 ( )^\circ\text{C}$                                   |                                                       |            | 0,3         | mA            |
| $V_{CE(TO)}$                   | $T_j = 25 (125)^\circ\text{C}$                                                               |                                                       | 1 (0,9)    | 1,2 (1,1)   | V             |
| $r_{CE}$                       | $V_{GE} = 15 \text{ V}, T_j = 25 (125)^\circ\text{C}$                                        |                                                       | 4,7 (7,3)  | 6,3 (9)     | m $\Omega$    |
| $V_{CE(sat)}$                  | $I_{Cnom} = 150 \text{ A}, V_{GE} = 15 \text{ V}, T_j = 25 (125)^\circ\text{C}$ , chip level |                                                       | 1,7 (2)    | 2,15 (2,45) | V             |
| $C_{ies}$                      | under following conditions                                                                   |                                                       | 10,8       |             | nF            |
| $C_{oes}$                      | $V_{GE} = 0, V_{CE} = 25 \text{ V}, f = 1 \text{ MHz}$                                       |                                                       | 0,6        |             | nF            |
| $C_{res}$                      |                                                                                              |                                                       | 0,5        |             | nF            |
| $L_{CE}$                       |                                                                                              |                                                       | 20         |             | nH            |
| $R_{CC'+EE'}$                  | terminal-chip, $T_c = 25 (125)^\circ\text{C}$                                                |                                                       | 0,7 (1)    |             | m $\Omega$    |
| $t_{d(on)}/t_r$                | $V_{CC} = 600 \text{ V}, I_{Cnom} = 150 \text{ A}$                                           |                                                       | 70 / 45    |             | ns            |
| $t_{d(off)}/t_f$               | $V_{GE} = \pm 15 \text{ V}$                                                                  |                                                       | 580 / 105  |             | ns            |
| $E_{on} (E_{off})$             | $R_{Gon} = R_{Goff} = 6,8 \Omega, T_j = 125^\circ\text{C}$                                   |                                                       | 15 (22)    |             | mJ            |
| <b>Inverse diode</b>           |                                                                                              |                                                       |            |             |               |
| $V_F = V_{EC}$                 | $I_{Fnom} = 150 \text{ A}; V_{GE} = 0 \text{ V}; T_j = 25 (125)^\circ\text{C}$ , chip level  |                                                       | 1,6 (1,6)  | 1,8 (1,8)   | V             |
| $V_{(TO)}$                     | $T_j = 25 (125)^\circ\text{C}$                                                               |                                                       | 1 (0,8)    | 1,1 (0,9)   | V             |
| $r_T$                          | $T_j = 25 (125)^\circ\text{C}$                                                               |                                                       | 4 (5,3)    | 4,7 (6)     | m $\Omega$    |
| $I_{RRM}$                      | $I_{Fnom} = 150 \text{ A}; T_j = 25 (125)^\circ\text{C}$                                     |                                                       | (240)      |             | A             |
| $Q_{rr}$                       | $di/dt = 4900 \text{ A}/\mu\text{s}$                                                         |                                                       | (42)       |             | $\mu\text{C}$ |
| $E_{rr}$                       | $V_{GE} = -15 \text{ V}$                                                                     |                                                       | (18)       |             | mJ            |
| <b>Thermal characteristics</b> |                                                                                              |                                                       |            |             |               |
| $R_{th(j-c)}$                  | per IGBT                                                                                     |                                                       |            | 0,14        | K/W           |
| $R_{th(j-c)D}$                 | per Inverse Diode                                                                            |                                                       |            | 0,33        | K/W           |
| $R_{th(j-c)FD}$                | per FWD                                                                                      |                                                       |            |             | K/W           |
| $R_{th(c-s)}$                  | per module                                                                                   |                                                       | 0,04       |             | K/W           |
| <b>Temperature sensor</b>      |                                                                                              |                                                       |            |             |               |
| $R_{25}$                       | $T_c = 25^\circ\text{C}$                                                                     |                                                       | 5 $\pm$ 5% |             | k $\Omega$    |
| $B_{25/85}$                    | $R_2 = R_1 \exp[B(1/T_2 - 1/T_1)]; T[K]; B$                                                  |                                                       | 3420       |             | K             |
| <b>Mechanical data</b>         |                                                                                              |                                                       |            |             |               |
| $M_s/M_t$                      | to heatsink (M5) / for terminals (M6)                                                        | 3/2,5                                                 |            | 5 / 5       | Nm            |
| w                              |                                                                                              |                                                       | 289        |             | g             |

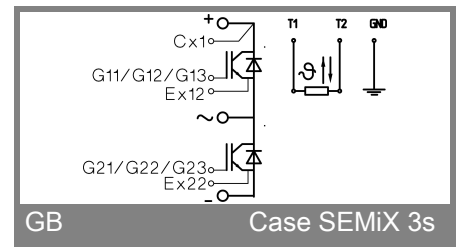
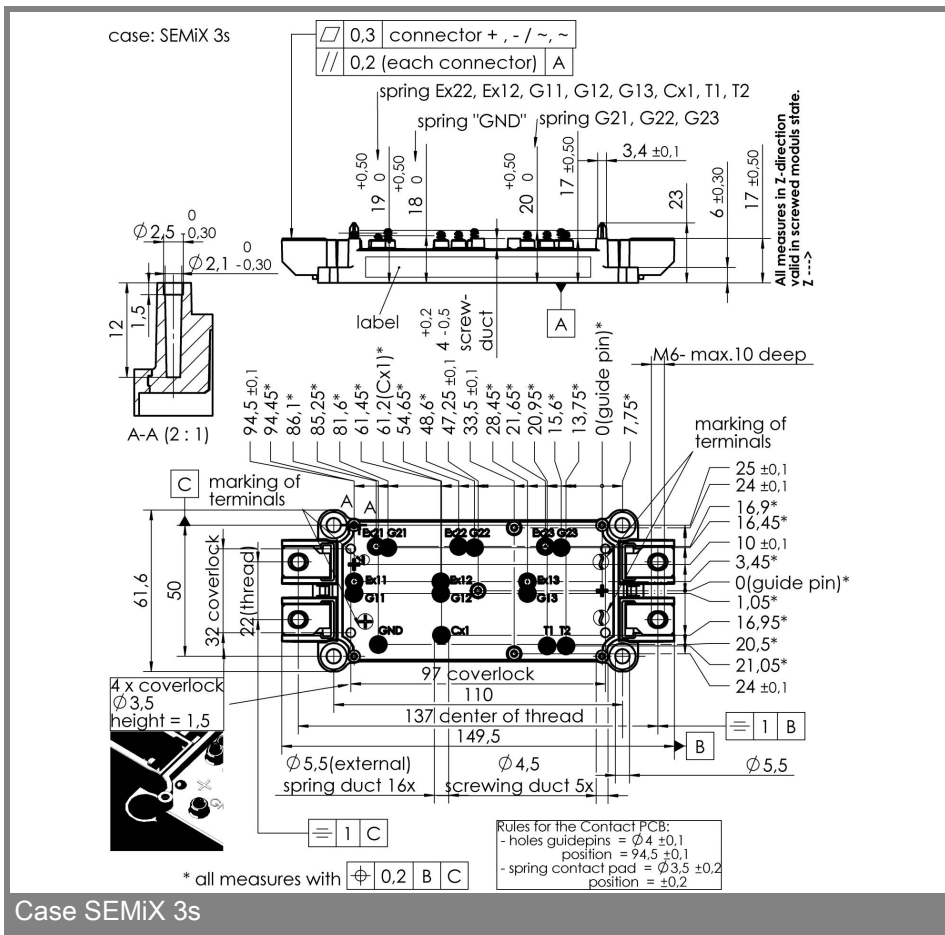
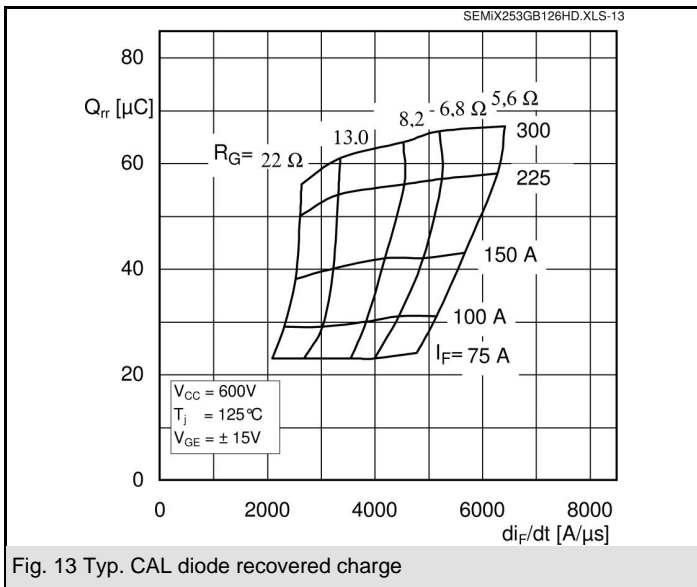


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This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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